

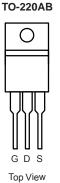
# N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>				
60	0.024 at V <sub>GS</sub> = 10 V	50				
00	0.028 at V <sub>GS</sub> = 4.5 V	40				

### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC





# N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25 °C, unless otherwise noted) PARAMETER SYMBOL LIMIT UNIT Drain-Source Voltage 60 V<sub>DS</sub> V Gate-Source Voltage ± 20 V<sub>GS</sub> T<sub>C</sub> = 25 °C Continuous Drain Current<sup>f</sup> 50 V<sub>GS</sub> at 10 V  $I_D$  $T_{C} = 100 \,^{\circ}C$ Continuous Drain Current 36 А 200 Pulsed Drain Currenta I<sub>DM</sub> Linear Derating Factor 1.0 W/°C Linear Derating Factor (PCB Mount)e 0.025 Single Pulse Avalanche Energy<sup>b</sup> E<sub>AS</sub> 400 mJ Maximum Power Dissipation T<sub>C</sub> = 25 °C 150 W  $P_D$ Maximum Power Dissipation (PCB Mount)e T<sub>A</sub> = 25 °C 3.7 Peak Diode Recovery dV/dtc dV/dt 4.5 V/ns Operating Junction and Storage Temperature Range - 55 to + 175 T<sub>J</sub>, T<sub>stg</sub> °C Soldering Recommendations (Peak Temperature)<sup>d</sup> 300<sup>d</sup> for 10 s

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 179 µH,  $R_g = 25 \Omega$ ,  $I_{AS} = 51 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 51 \text{ A}$ , dl/dt  $\le 250 \text{ A/µs}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

d. 1.6 mm from case.

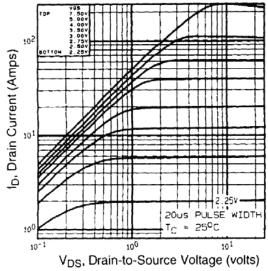
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THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	ТҮР		MAX.			UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62					
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-		40		°C/W			
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 1.0							
ote . When mounted on 1" square PCB (FR-4	or G-10 material)	). 1							
SPECIFICATIONS (T_J = 25 $^{\circ}$ C, u	nless otherw	ise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS MIN.		TYP.	MAX.	UNIT			
Static		•							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = 250 μA		60	-	-	V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.070	-	V/°C		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		1.0	-	2.5			
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 10 V$		-	-	± 100	nA		
		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48 V,	$48 \text{ V}, \text{ V}_{\text{GS}} = 0 \text{ V}, \text{ T}_{\text{J}} = 150 ^{\circ}\text{C}$		-	-	250	μA	
		V <sub>GS</sub> = 10 V	I <sub>D</sub>	= 21 A <sup>b</sup>	_	0.024	-	1	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V	I <sub>D</sub>	= 15 A <sup>b</sup>	-	0.028	-	Ω	
Forward Transconductance	g <sub>fs</sub>	$V_{DS} = 25 \text{ V}, \text{ I}_{D} = 21 \text{ A}^{\text{b}}$		23	-	-	S		
Dynamic					1	I			
Input Capacitance	C <sub>iss</sub>				-	190			
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		_	920	-	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>			_	170	-			
Total Gate Charge	Qg				-	-	66	<u> </u>	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 5.0 V$ $I_D = 51 A, V_{DS} = 48 V,$		_	-	12	nC		
Gate-Drain Charge	Q <sub>gd</sub>		see fig. 6 and 13 <sup>b</sup>		_	-	43	1	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 30 V, I <sub>D</sub> = 51 A, R <sub>g</sub> = 4.6 Ω, R <sub>D</sub> = 0.56 Ω, see fig. 10 <sup>b</sup>		-	17	_	-		
Rise Time	tr			_	230	-			
Turn-Off Delay Time	t <sub>d(off)</sub>				_	2	_	ns	
Fall Time	t <sub>f</sub>			_	110	_	-		
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	L <sub>S</sub>			-	7.5	-			
Drain-Source Body Diode Characteristic	cs	•							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50 <sup>c</sup>	A		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	200			
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25 \ ^{\circ}C, \ I_S = 51 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_{\rm J} = 25 \ ^{\circ}{\rm C}, \ I_{\rm F} = 51 \ {\rm A}, \ {\rm d}{\rm I}/{\rm dt} = 100 \ {\rm A}/\mu{\rm s}^{\rm b}$		-	130	180	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.84	1.3	μC		
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by				ul and			

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



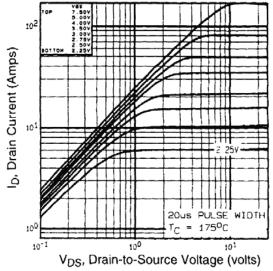
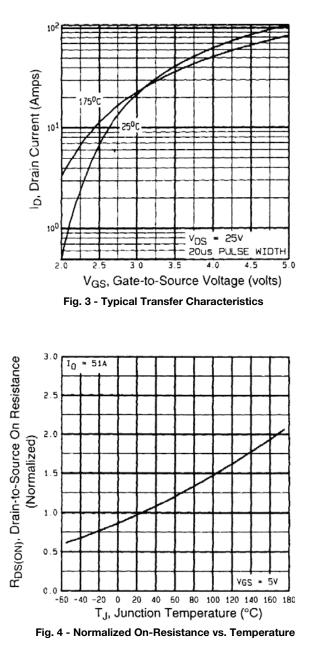


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C





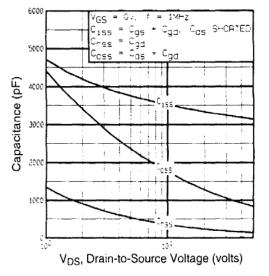


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

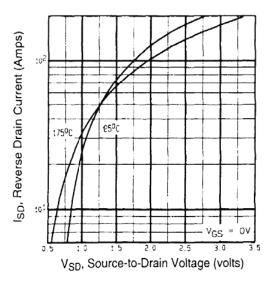
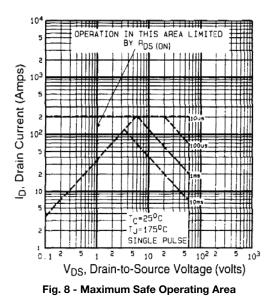


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





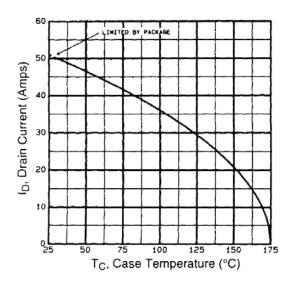


Fig. 9 - Maximum Drain Current vs. Case Temperature

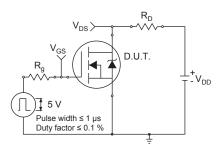


Fig. 10a - Switching Time Test Circuit

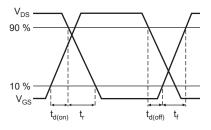


Fig. 10b - Switching Time Waveforms

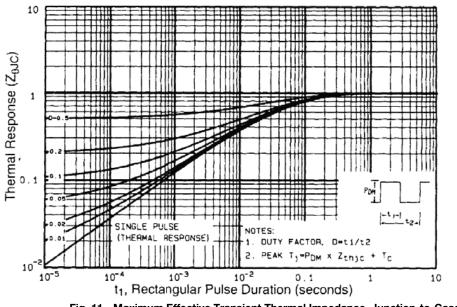


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



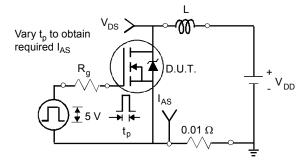


Fig. 12a - Unclamped Inductive Test Circuit

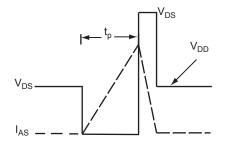


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

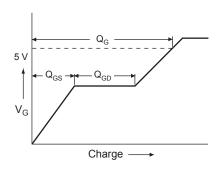


Fig. 13a - Basic Gate Charge Waveform

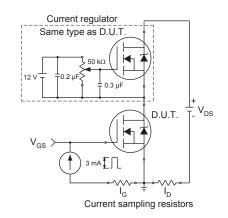
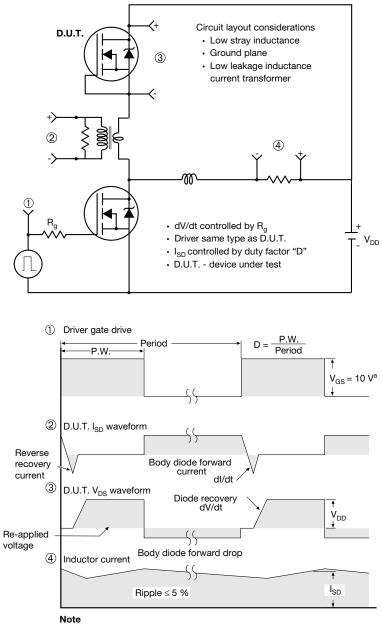


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

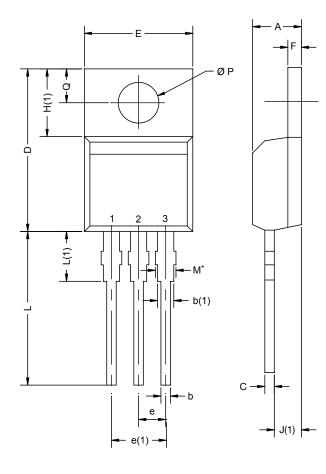


a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



### **TO-220AB**



	MILLIN	IETERS	INC	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.		
А	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØΡ	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12				

### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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